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| FORM PTO-1449 (Modified) | JUN 28 2004 RECEIVED USPTO JC99 | ATTY. DOCKET NO. USIS920030247US1 | SERIAL NO. 10/605,672 |
| LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT | | APPLICANT: Bruce B. Doris, et al. | |
| (Use several sheets if necessary) | | FILING DATE: 10/16/03 | GROUP: 2812 |

| REFERENCE DESIGNATION | | U.S. PATENT DOCUMENTS | | | | |
|-----------------------|--------------------|-----------------------|----------------|-------|----------|-------------------------|
| EXAMINER INITIALS | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE (IF APPRO.) |
| SDI | 6,228,694 B1 | 5/8/2001 | Doyle et al. | | | |
| | 6,406,973 B1 | 6/18/2002 | Lee | | | |
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| | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | TRANSLATION |
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| | | | | | | YES |

OTHER ART (including Author, Title, Date, Pertinent Pages, etc.)

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| EXAMINER | <i>Stanetta Isaac</i> | DATE CONSIDERED | <i>4/30/05</i> |
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| SDE | 5,081,513 | 1/14/1992 | Jackson, et al. | | | |
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| SDS | 5,940,736 | 8/17/1999 | Brady, et al. | | | |
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| SDT | 5,989,978 | 11/23/1999 | Peidous | | | | |
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| | 6,221,735 | 4/24/2001 | Manley, et al. | | | | |
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| SDF | 5,557,122 | 9/17/1996 | Shrivastava, et al. | | | |
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| | 6,319,794 | 11-20-2001 | Akatsu et al. | | | |
| | 2001/0009784 | 07-26-2001 | Ma et al. | | | |

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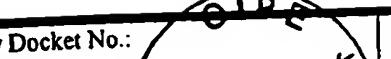
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| Form PTO-1449 (Modified) LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary) | Page 1 of 1 |  Attorney Docket No.: FIS920030247 | Serial No.: 10/605,672 |
| | | Applicant: Bruce B. Doris, et al. | Group: 2812 |
| | | Filing Date: 10/16/03 | |

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| | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | | YES | NO |
| SDF | 2000-269466 | 09-29-2000 | Japan | | | | <input checked="" type="checkbox"/> | <input type="checkbox"/> |
| SDF | 57-80733 | 05-20-1982 | Japan | | | | <input checked="" type="checkbox"/> | <input type="checkbox"/> |

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| SDF | Kern Rim, et al., "Transconductance Enhancement in Deep Submicron Strained-Si <i>n</i> -MOSFETs", International Electron Devices Meeting, 26, 8, 1, IEEE, September 1998. |
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| | A. Shimizu, et al., "Local Mechanical-Stress Control (LMC): A New Technique for CMOS-Performance Enhancement", International Electron Devices Meeting, IEEE, March 2001. |
| | K. Ota, et al., "Novel Locally Strained Channel Technique for high Performance 55nm CMOS", International Electron Devices Meeting, 2.2.1, IEEE, February 2002. |

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